Silicon Controlled Rectifiers

Reverse Blocking Thyristors

Designed primarily for half-wave ac control applications, such as motor controls, heating controls and power supplies; or wherever half-wave silicon gate-controlled, solid-state devices are needed.

Features

- Glass-Passivated Junctions
- Blocking Voltage to 400 Volts
- TO-220 Construction Low Thermal Resistance, High Heat Dissipation and Durability

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Rating	Symbol	Value	Unit
Peak Repetitive Off-State Voltage (Note 1) (T _J = -40 to 125°C, Gate Open) MCR218-2G MCR218-4G MCR218-6G	V _{DRM,} V _{RRM}	50 200 400	V
On-State RMS Current (180° Conduction Angles; T _C = 70°C)	I _{T(RMS)}	8.0	Α
Peak Non-repetitive Surge Current (1/2 Cycle, Sine Wave 60 Hz, T _J = 125°C)	I _{TSM}	100	Α
Circuit Fusing Considerations (t = 8.3 ms)	l ² t	26	A ² s
Forward Peak Gate Power (Pulse Width \leq 1.0 μ s, T _C = 70°C)	P _{GM}	5.0	W
Forward Average Gate Power (t = 8.3 ms, T _C = 70°C)	P _{G(AV)}	0.5	W
Forward Peak Gate Current (Pulse Width \leq 1.0 μ s, T _C = 70°C)	I _{GM}	2.0	Α
Operating Junction Temperature Range	T_J	-40 to +125	°C
Storage Temperature Range	T _{stg}	-40 to +150	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

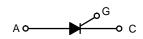
 V_{DRM} and V_{RRM} for all types can be applied on a continuous basis. Ratings apply for zero or negative gate voltage; however, positive gate voltage shall not be applied concurrent with negative potential on the anode. Blocking voltages shall not be tested with a constant current source such that the voltage ratings of the devices are exceeded.



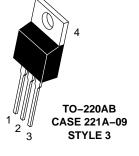
ON Semiconductor®

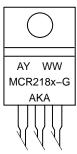
www.onsemi.com

SCRs 8 AMPERES RMS 50 thru 400 VOLTS



MARKING DIAGRAM





= Assembly Location
= Year
WW = Work Week

AKA = Diode Polarity

ORDERING INFORMATION

Device	Package	Shipping
MCR218-2G	TO220AB (Pb-Free)	500 Units/Bulk
MCR218-4G	TO220AB (Pb-Free)	500 Units/Bulk
MCR218-6G	TO220AB (Pb-Free)	500 Units/Bulk

^{*}For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

THERMAL CHARACTERISTICS

Characteristic	Symbol	Max	Unit
Thermal Resistance, Junction-to-Case	$R_{ heta JC}$	2.0	°C/W
Maximum Lead Temperature for Soldering Purposes 1/8" from Case for 10 Seconds	T_L	260	°C

ELECTRICAL CHARACTERISTICS (T_{.1} = 25°C unless otherwise noted.)

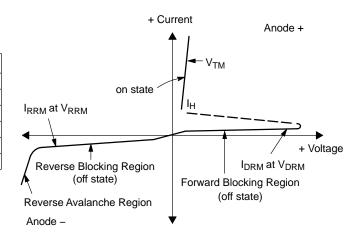
Characteristic	Symbol	Min	Тур	Max	Unit
OFF CHARACTERISTICS	•			•	
Peak Repetitive Forward or Reverse Blocking Current $ (V_{AK} = \text{Rated V}_{DRM} \text{ or V}_{RRM}, \text{ Gate Open}) \qquad \qquad T_J = 25^{\circ}\text{C} \\ T_J = 125^{\circ}\text{C} $	I _{DRM} , I _{RRM}	_ _	_ _	10 2.0	μA mA
ON CHARACTERISTICS			ı	UI	ı
Peak Forward On-State Voltage (Note 2) (I _{TM} = 16 A Peak)	V _{TM}	-	1.5	1.8	V
Gate Trigger Current (Continuous dc) (V _D = 12 V, R _L = 100 Ohms)	I _{GT}	-	10	25	mA
Gate Trigger Voltage (Continuous dc) (V _D = 12 V, R _L = 100 Ohms)	V _{GT}	_	-	1.5	V
Gate Non–Trigger Voltage (Rated 12 V, R _L = 100 Ohms, T _J = 125°C)	V_{GD}	0.2	-	-	V
Holding Current (V _D = 12 Vdc, Initiating Current = 200 mA, Gate Open)	I _H	-	16	30	mA
DYNAMIC CHARACTERISTICS				•	
Critical Rate-of-Rise of Off-State Voltage $(V_D = Rated\ V_{DRM},\ Exponential\ Waveform,\ Gate\ Open,\ T_J = 125^{\circ}C)$	dv/dt	-	100	_	V/μs

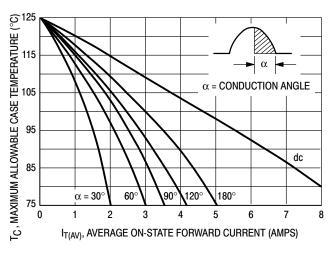
Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

2. Pulse Test: Pulse Width = 1.0 ms, Duty Cycle ≤ 2%.

Voltage Current Characteristic of SCR

Symbol	Parameter
V_{DRM}	Peak Repetitive Off State Forward Voltage
I _{DRM}	Peak Forward Blocking Current
V _{RRM}	Peak Repetitive Off State Reverse Voltage
I _{RRM}	Peak Reverse Blocking Current
V _{TM}	Peak On State Voltage
I _H	Holding Current





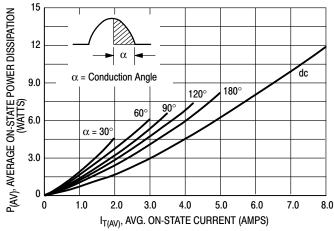
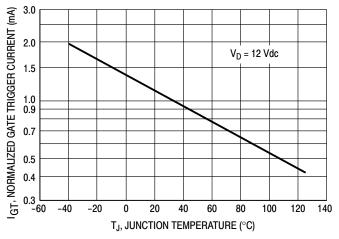


Figure 1. Current Derating

Figure 2. On-State Power Dissipation



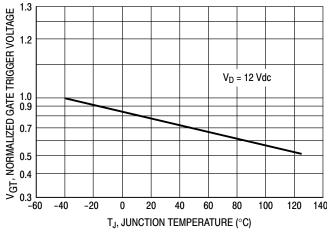


Figure 3. Typical Gate Trigger Current versus Temperature

Figure 4. Typical Gate Trigger Voltage versus Temperature

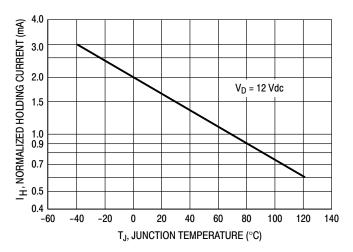
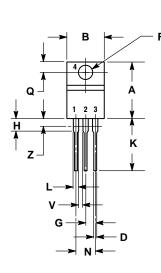
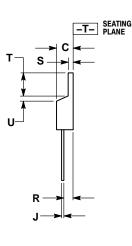


Figure 5. Typical Holding Current versus Temperature

PACKAGE DIMENSIONS

TO-220 CASE 221A-09 **ISSUE AH**





NOTES

- DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982. CONTROLLING DIMENSION: INCH.
- DIMENSION Z DEFINES A ZONE WHERE ALL BODY AND LEAD IRREGULARITIES ARE

	INCHES		MILLIMETERS	
DIM	MIN	MAX	MIN	MAX
Α	0.570	0.620	14.48	15.75
В	0.380	0.415	9.66	10.53
С	0.160	0.190	4.07	4.83
D	0.025	0.038	0.64	0.96
F	0.142	0.161	3.61	4.09
G	0.095	0.105	2.42	2.66
Н	0.110	0.161	2.80	4.10
ſ	0.014	0.024	0.36	0.61
K	0.500	0.562	12.70	14.27
L	0.045	0.060	1.15	1.52
N	0.190	0.210	4.83	5.33
Q	0.100	0.120	2.54	3.04
R	0.080	0.110	2.04	2.79
S	0.045	0.055	1.15	1.39
Т	0.235	0.255	5.97	6.47
U	0.000	0.050	0.00	1.27
٧	0.045		1.15	
Z		0.080		2.04

STYLE 3:

PIN 1. CATHODE

- 2. ANODE
- GATE
- ANODE

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